


<b>Search Notes</b>  	<b>Application/Control No.</b>  10677216	<b>Applicant(s)/Patent Under Reexamination</b>  UCHIDA, TAKAYUKI
	<b>Examiner</b>  Veillard, Jacques	<b>Art Unit</b>  2165

SEARCHED			
Class	Subclass	Date	Examiner
707	1 - 7, 10, 100, 102, 104.1	4/24/2007	J.V
709	203, 218, 224	4/24/2007	J.V

SEARCH NOTES		
Search Notes	Date	Examiner
EIC Plus Database Search Prepared by Sira Staff	4/6/2007	J.V
Consulted with G. Robinson P.E AU 2167, reviewed the amendment	4/24/2007	J.V
Updated West Electronic Database Search	4/24/2007	J.V
ACM Electronic Database Search	4/24/2007	J.V

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
707	3, 100, 104.1	4/24/2007	J.V